

**Notice of References Cited**

Application/Control No.

10/510,263

Applicant(s)/Patent Under  
Reexamination  
BADHEI ET AL.

Examiner

W. Wendy Kuo

Art Unit

2826

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,451,119	05-1984	Meyers et al.	359/846
*	B	US-5,600,741	02-1997	Hauer et al.	385/35
*	C	US-6,869,229 B2	03-2005	Reedy et al.	385/88
*	D	US-2001/0004413 A1	06-2001	Aihara, Shuichi	385/88
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.